

MOS FIELD EFFECT TRANSISTOR μ PA1813

P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The μ PA1813 is a switching device which can be driven directly by a 2.5-V power source.

The μ PA1813 features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

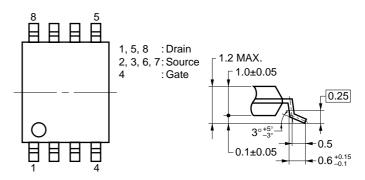
- Can be driven by a 2.5-V power source
- · Low on-state resistance

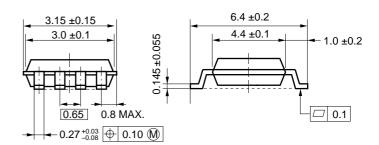
$$\begin{split} &\text{RDS}(\text{on})\text{1} = 25 \text{ m}\Omega \text{ MAX. (VGS} = -4.5 \text{ V, ID} = -2.5 \text{ A)} \\ &\text{RDS}(\text{on})\text{2} = 30 \text{ m}\Omega \text{ MAX. (VGS} = -4.0 \text{ V, ID} = -2.5 \text{ A)} \\ &\text{RDS}(\text{on})\text{3} = 40 \text{ m}\Omega \text{ MAX. (VGS} = -2.5 \text{ V, ID} = -2.5 \text{ A)} \end{split}$$

ORDERING INFORMATION

PART NUMBER	PACKAGE
μPA1813GR-9JG	Power TSSOP8

PACKAGE DRAWING (Unit: mm)

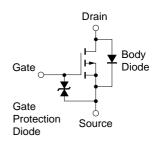




ABSOLUTE MAXIMUM RATINGS (T_A = 25°C)

Drain to Source Voltage	VDSS	-12	V
Gate to Source Voltage	Vgss	-10/+5	V
Drain Current (DC)	ID(DC)	±5.0	Α
Drain Current (pulse) Note1	I _{D(pulse)}	±20	Α
Total Power Dissipation Note2	Рт	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C

EQUIVALENT CIRCUIT



- **Notes 1.** PW \leq 10 μ s, Duty Cycle \leq 1 %
 - 2. Mounted on ceramic substrate of 5000 mm² x 1.1 mm

Remark

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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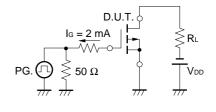
ELECTRICAL CHARACTERISTICS (T_A = 25 °C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = −12 V, V _{GS} = 0 V			-10	μΑ
Gate Leakage Current	Igss	Vgs = ±10 V, Vps = 0 V			±10	μΑ
Gate Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-0.5	-0.92	-1.5	V
Forward Transfer Admittance	y _{fs}	$V_{DS} = -10 \text{ V}, I_{D} = -2.5 \text{ A}$	1	13		S
Drain to Source On-state Resistance	RDS(on)1	V _G S = -4.5 V, I _D = -2.5 A		19	25	mΩ
	RDS(on)2	Vgs = -4.0V, ID = -2.5 A		21	30	mΩ
	RDS(on)3	Vgs = -2.5 V, ID = -2.5 A		28	40	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V		1130		pF
Output Capacitance	Coss	V _G S = 0 V		1045		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		350		pF
Turn-on Delay Time	td(on)	V _{DD} = -10 V		29		ns
Rise Time	tr	I _D = -2.5 A		180		ns
Turn-off Delay Time	td(off)	$V_{GS(on)} = -4.0 \text{ V}$		665		ns
Fall Time	t _f	$R_G = 10 \Omega$		1255		ns
Total Gate Charge	Q _G	V _{DS} = -10 V		24		nC
Gate to Source Charge	Qgs	I _D = -5.0 A		5.1		nC
Gate to Drain Charge	Q _{GD}	Vgs = -4.0 V		10		nC
Diode Forward Voltage	V _{F(S-D)}	IF = 5.0 A, VGS = 0 V		0.77		V
Reverse Recovery Time	trr	IF = 5.0 A, Vgs = 0 V		45		ns
Reverse Recovery Charge	Qrr	di/dt = 10 A/μs		6.2		nC

TEST CIRCUIT 1 SWITCHING TIME

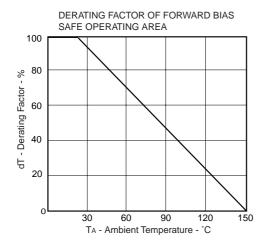
PG. $\bigcap_{RG} RG = 10 \Omega$ V_{DD} V_{GS} $V_{Wave Form}$ $V_{Wave Form}$ V_{US} V_{US}

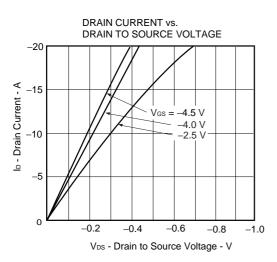
TEST CIRCUIT 2 GATE CHARGE

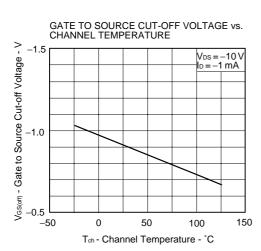


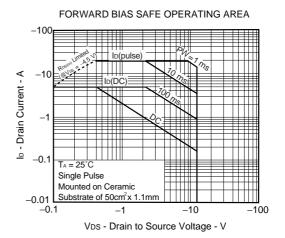


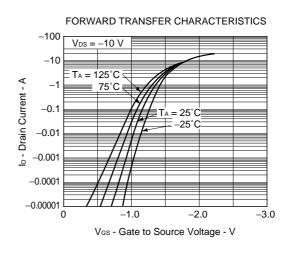
TYPICAL CHARACTERISTICS (TA = 25 °C)

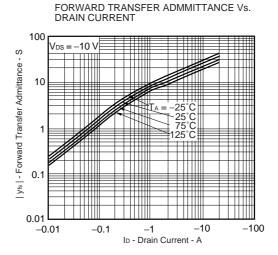




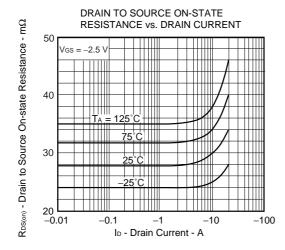


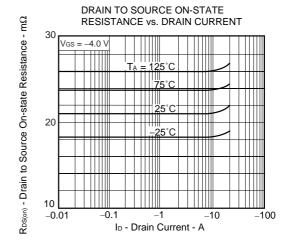


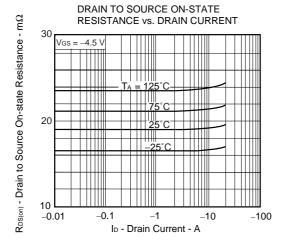


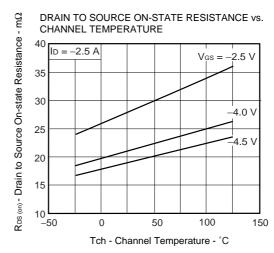


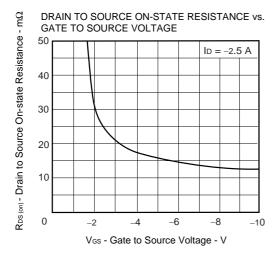
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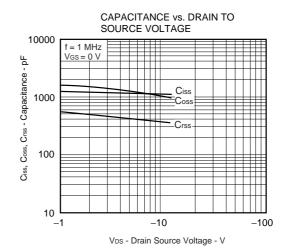




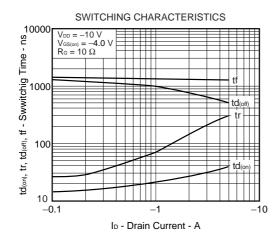


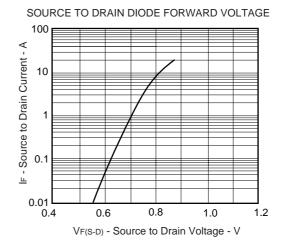


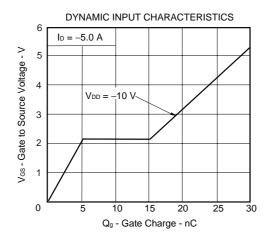




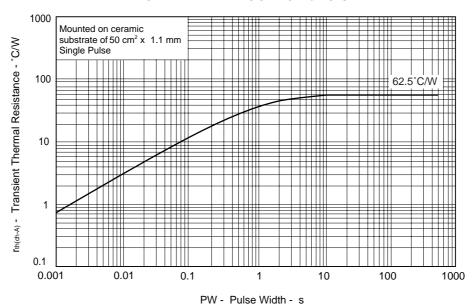








TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



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